Search Notes			

Application No.	Applicant(s)	
09/736,078	LEE ET AL.	
Examiner	Art Unit	
Afsar M Oureshi	2667	

SEARCHED			
Class	Subclass	Date	Examiner
370	216	1/12/2005	AQ
	228		
	238		
	256		
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
370	216	1/11/2005	AQ
	238		
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